

Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$

Product Summary**BVDSS****RDS(on)****ID**

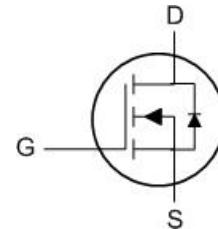
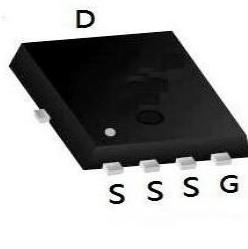
40V

4.6mΩ

70A

Applications

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

PDFN3333-8L Pin Configuration**Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_c = 25^\circ C$	Continuous Drain Current ¹	70	A
$I_D @ T_c = 100^\circ C$	Continuous Drain Current ¹	38	A
I_{DM}	Pulsed Drain Current ²	240	A
EAS	Single Pulse Avalanche Energy ³	45	mJ
I_{AS}	Avalanche Current	15	A
$P_D @ T_c = 25^\circ C$	Total Power Dissipation ⁴	35.7	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient (Steady State) ¹	---	60	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	---	3.5	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	1 €	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	---	---	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=10\text{V}$, $I_D=0\text{EA}$	---	1 €	1	{
		$V_{\text{GS}}=1 \text{--} V$, $I_D=F\text{EA}$	---	1	1	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	F€G	F€E	G€G	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		---	---	---	$\text{mV}/^\circ\text{C}$
$I_{\text{DS}(\text{SS})}$	Drain-Source Leakage Current	$V_{\text{DS}}=1 \text{--} \text{EV}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	uA
		$V_{\text{DS}}=1 \text{--} \text{EV}$, $V_{\text{GS}}=0\text{V}$, $T_J=100^\circ\text{C}$	---	---	100	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 0\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	$\pm F\text{E}0$	nA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=1 \text{--} \text{V}$, $I_D=5.5\text{A}$	---	1	1	S
R_g	Gate Resistance	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	F€E	---	Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=0\text{EV}$, $V_{\text{GS}}=10\text{V}$, $I_D=0\text{EA}$	---	F1	---	nC
Q_{gs}	Gate-Source Charge		---	H€E	---	
Q_{gd}	Gate-Drain Charge		---	G€E	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}}=10\text{V}$, $V_{\text{DD}}=0\text{EV}$, $R_G=H\Omega$, $I_D=0\text{EA}$	---	1 €	---	ns
T_r	Rise Time		---	F€E	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	F1 E	---	
T_f	Fall Time		---	H€E	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=0\text{EV}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	FF1 €	---	pF
C_{oss}	Output Capacitance		---	G1	---	
C_{rss}	Reverse Transfer Capacitance		---	FG€	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ^{1,4}	$V_G=V_D=0\text{V}$, Force Current	---	---	70	A
V_{SD}	Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}$, $I_s=20\text{A}$, $T_J=25^\circ\text{C}$	---	---	1.2	V
t_{rr}	Reverse Recovery Time	$I_F=20\text{A}$, $di/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	25	---	nS
			---	6	---	nC

Note :

F1 The data is tested by a surface mounted on a 1 inch² FR-4 board with 2oz copper.

G1 The data is tested by a pulsed pulse width < 300us, duty cycle < 2%.

H1 The EAS data shows Max Rating at the test condition as A/RMIG > 0, VDD=25V, VGS=10V, L=0.4mH, IAS=15A.

I1 The power dissipation is limited by 50°C junction temperature.

J1 The data is theoretically the same as A_{D} and A_{DM} . In real applications, it should be limited by total power dissipation.

Typical Characteristics

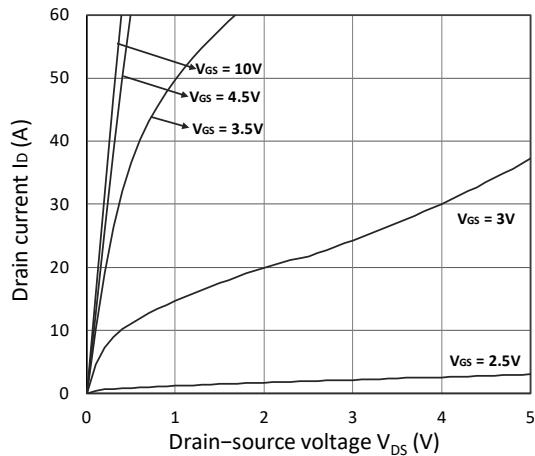


Figure 1. Output Characteristics

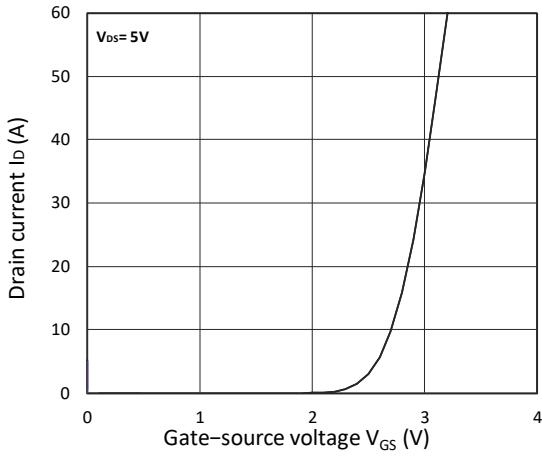


Figure 2. Transfer Characteristics

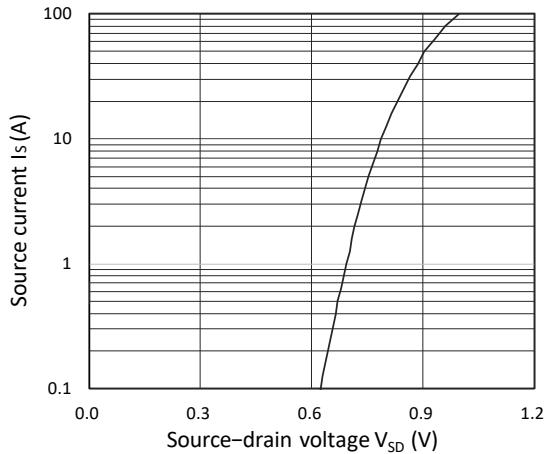
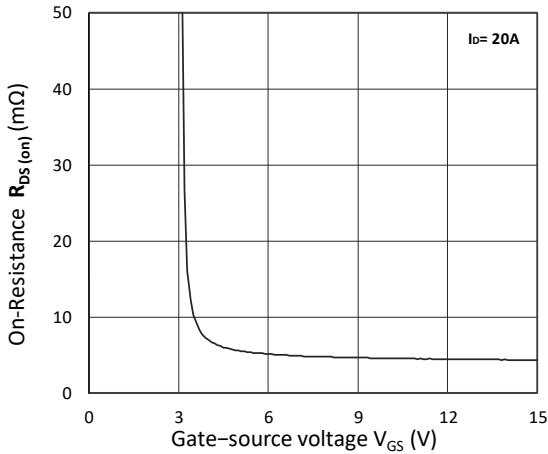
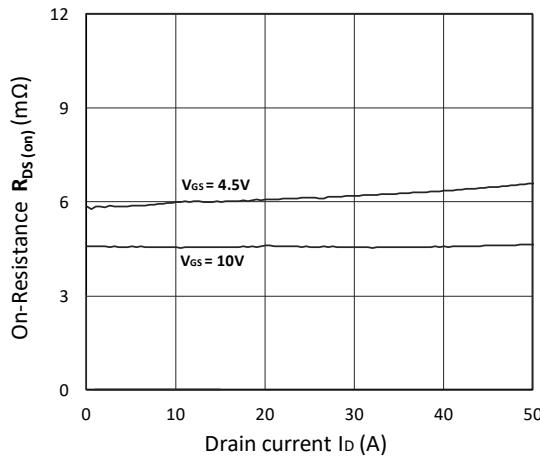
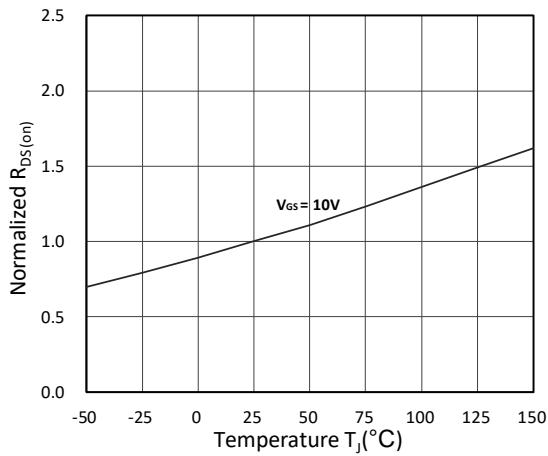


Figure 3. Forward Characteristics of Reverse

Figure 4. $R_{DS(on)}$ vs. V_{GS} Figure 5. $R_{DS(on)}$ vs. I_D Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

N-Ch 40V Fast Switching MOSFETs

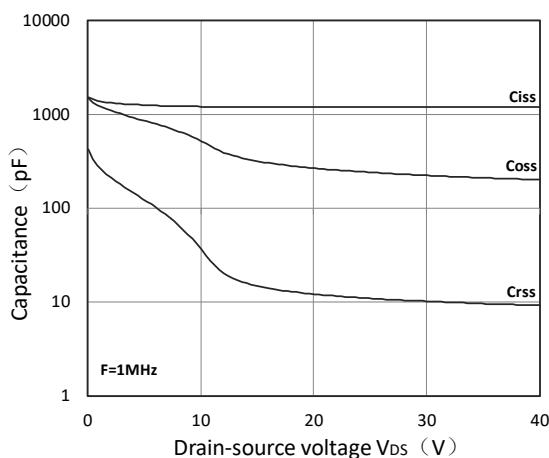


Figure 7. Capacitance Characteristics

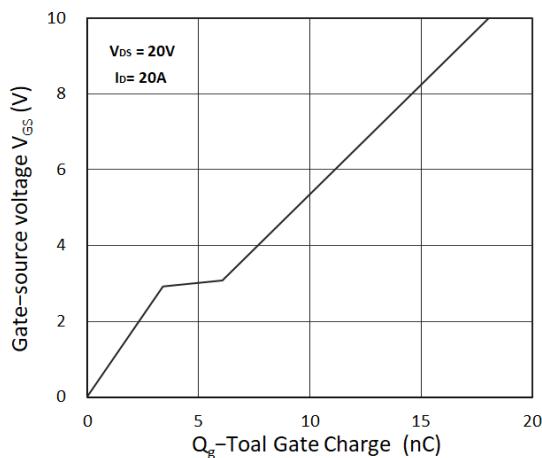


Figure 8. Gate Charge Characteristics

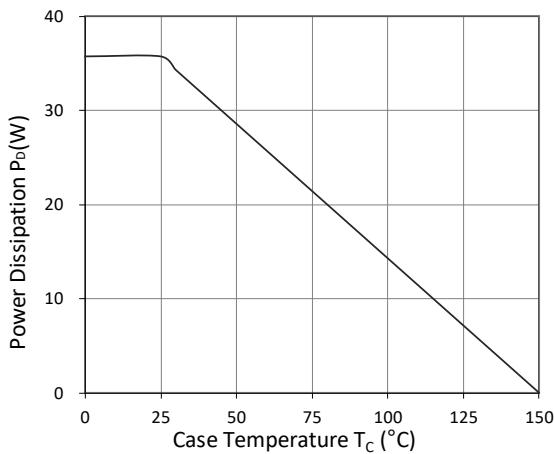


Figure 9. Power Dissipation

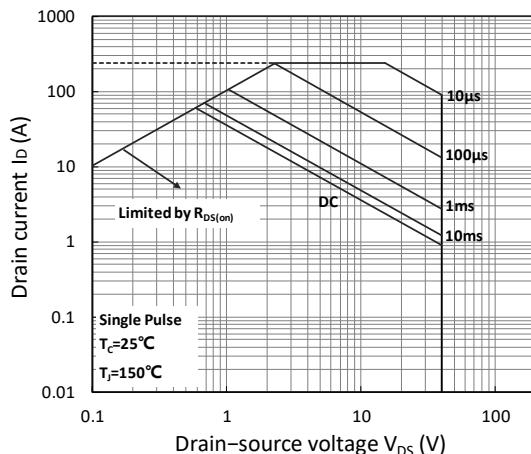


Figure 10. Safe Operating Area

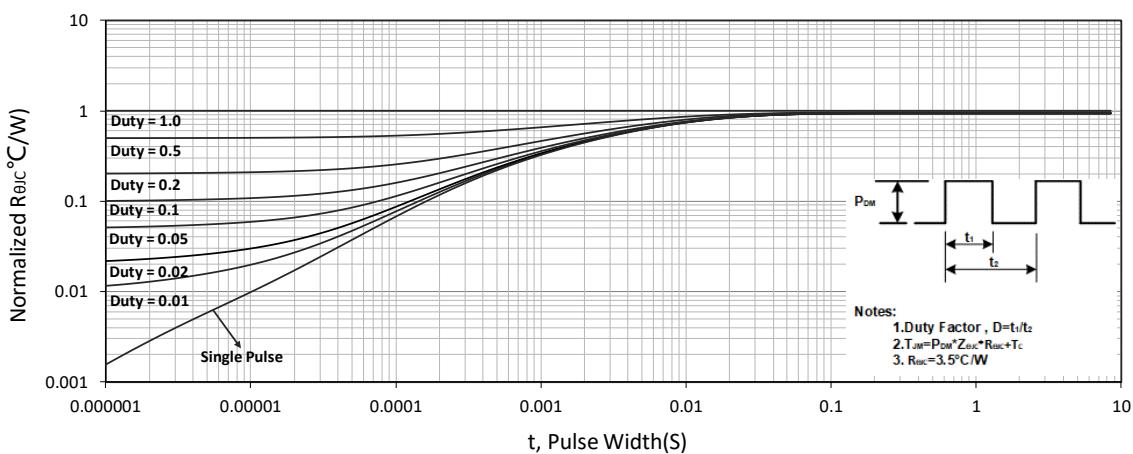
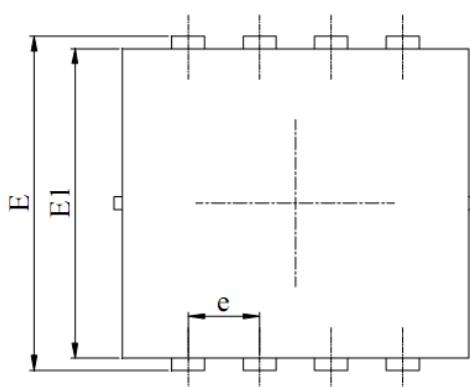
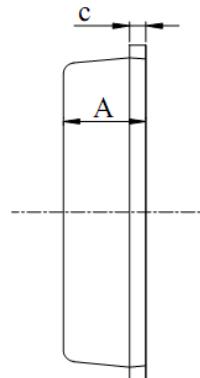


Figure 11. Normalized Maximum Transient Thermal Impedance

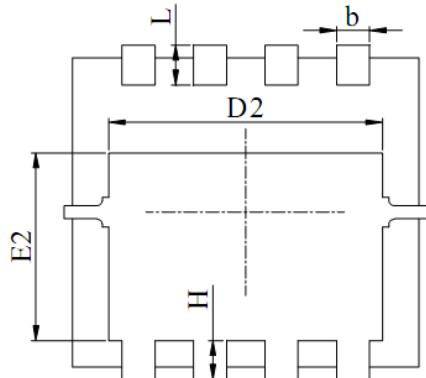
Package Mechanical Data-PDFN3333-8L-Single



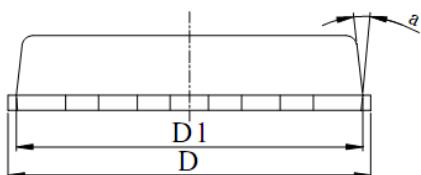
Top View



Side View



Bottom View

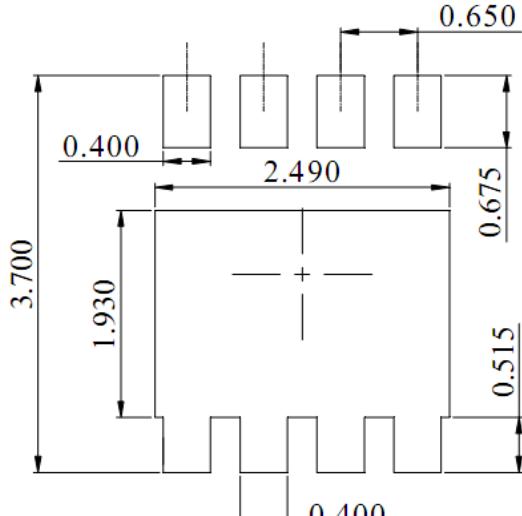


Front View

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M,1994.
2. ALL DIMNESIONS IN MILLIMETER (ANGLE IN DEGREE).
3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.20	0.25
D	3.00	3.15	3.25
D1	2.95	3.05	3.15
D2	2.39	2.49	2.59
E	3.20	3.30	3.40
E1	2.95	3.05	3.15
E2	1.70	1.80	1.90
e	0.65 BSC		
H	0.30	0.40	0.50
L	0.25	0.40	0.50
a	---	---	15°



DIMENSIONS: MILLIMETERS